Silicon N-channel IGBT 3300V F version

FEATURES

- * Soft switching behavior, low switching loss & low conduction loss :
 - Soft low-injection punch-through
 - Advanced Trench High conductivity IGBT.
- * Low driving power due to low input capacitance with trench MOS gate.
- * Low noise recovery: Ultra soft fast recovery diode.
- * High Current rate Package.
- * Low R_{th(j-c)} & low stray inductance.
- * RoHS

ABSOLUTE MAXIMUM RATINGS (T_C=25°C)

Item		Symbol	Unit	MBN1800FH33F
Collector Emitter Voltage		V _{CES}	V	3,300
Gate Emitter Voltage		V _{GES}	V	±20
Collector Current	DC	lc	•	1,800
	1ms	ICRM	— A	3,600
Forward Current	DC	l _F	•	1,800
	1ms	I _{FRM}	— A	3,600
Junction Temperature	•	T _{vj op}	°C	-50 ~ +150
Storage Temperature		T _{stg}	°C	-50 ~ +150
Isolation Voltage		V _{ISO}	V _{RMS}	10,200(AC 1 minute)
Screw Torque	Terminals (M4/M8)	-	N·m -	2/10 (1)
	Mounting (M6)	-		6 (2)

Notes: (1) Recommended Value 1.8±0.2/9±1N·m (2) Recommended Value 5.5±0.5N·m

ELECTRICAL CHARACTERISTICS

Item		Symbol	Unit	Min.	Тур.	Max.	Test Conditions
Collector Emitter Cut-Off Current		I _{CES}	mA	-	-	0.6	V _{CE} =3,300V, V _{GE} =0V, T _{vj} =25°C
				-	40	100	V _{CE} =3,300V, V _{GE} =0V, T _{vj} =150°C
Gate Emitter Leakage Current		I _{GES}	nA	-500	-	+500	$V_{GE}=\pm 20V, V_{CE}=0V, T_{vj}=25^{\circ}C$
Collector Emitter Saturation Voltage		V _{CEsat}	V	2.5	2.85	3.5	I _C =1,800A, V _{GE} =15V, T _{vj} =150°C
Gate Emitter Threshold Voltage		V _{GE(th)}	V	5.5	6.5	7.5	V _{CE} =10V, I _C =1,800mA, T _{vj} =25°C
Input Capacitance		Cies	nF	-	132	-	V _{CE} =10V, V _{GE} =0V, f=100kHz, T _{vj} =25°C
Internal Gate Resistance		R _{G(int)}	Ω	-	1.3	-	V _{CE} =10V, V _{GE} =0V, f=100kHz, T _{vj} =25°C
Turn On Delay Time		t _{d(on)}	μs -	-	0.8	-	V _{CC} =1,800V, I _C =1,800A
Rise Time		tr		-	0.3	-	L _S =100nH
Turn Off Delay Time		t _{d(off)}		-	2.2	-	$R_{G}(\text{on/off})=4.7\Omega/5.6\Omega (3)$
Fall Time		t _f		-	1.8	-	V _{GE} =±15V, T _{vj} =150°C
Forward Voltage Drop		VF	V	2.2	2.6	2.9	I _F =1,800A, V _{GE} =0V, T _{vj} =150°C
Reverse Recovery Time		t _{rr}	μS	-	0.7	-	V _{CC} =1,800V, I _F =1,800A, L _S =100nH
							T _{vi} =150°C
Turn On Loss		Eon	J/P	-	3.7	-	V _{CC} =1,800V, I _C =1,800A, L _S =100nH
Turn Off Loss		Eoff	J/P	-	3.3	-	$R_{G}(\text{on/off})=4.7\Omega/5.6\Omega \qquad (3)$
Reverse Recovery Loss		Err	J/P	-	2.4	-	V _{GE} =±15V, T _{vj} =150°C
Short Circuit Pulse Width		t _{sc}	μS	10	-	-	V _{CC} =2,000V, Ls=100nH
							$R_{G}(on/off) = 4.7/56\Omega, V_{GF} = \pm 15V, T_{vj} = 150^{\circ}C$
Stray inductance module		L _{SCE}	nH	-	12	-	
Thermal Impedance	BT	R _{th(j-c)}	K/W	-	-	0.0075	Junction to case
· F'	ND	R _{th(j-c)}		-	-	0.0125	
Contact Thermal Impedance		R _{th(c-f})	K/W	-	0.005	-	Case to fin

Notes: (3) R_G value is a test condition value for evaluation, not recommended value.

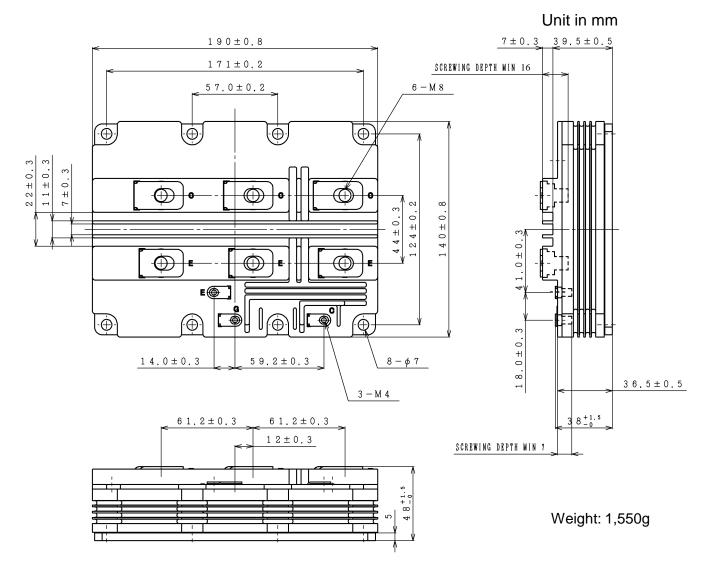
Please, determine the suitable R_G value by measuring switching behaviors.

* Please contact our representatives at order.

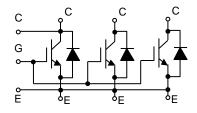
- * For improvement, specifications are subject to change without notice.
- * For actual application, please confirm this spec sheet is the newest revision.

* ELECTRICAL CHARACTERISTIC items shown in above table are according to IEC 60747-2 and IEC 60747-9.

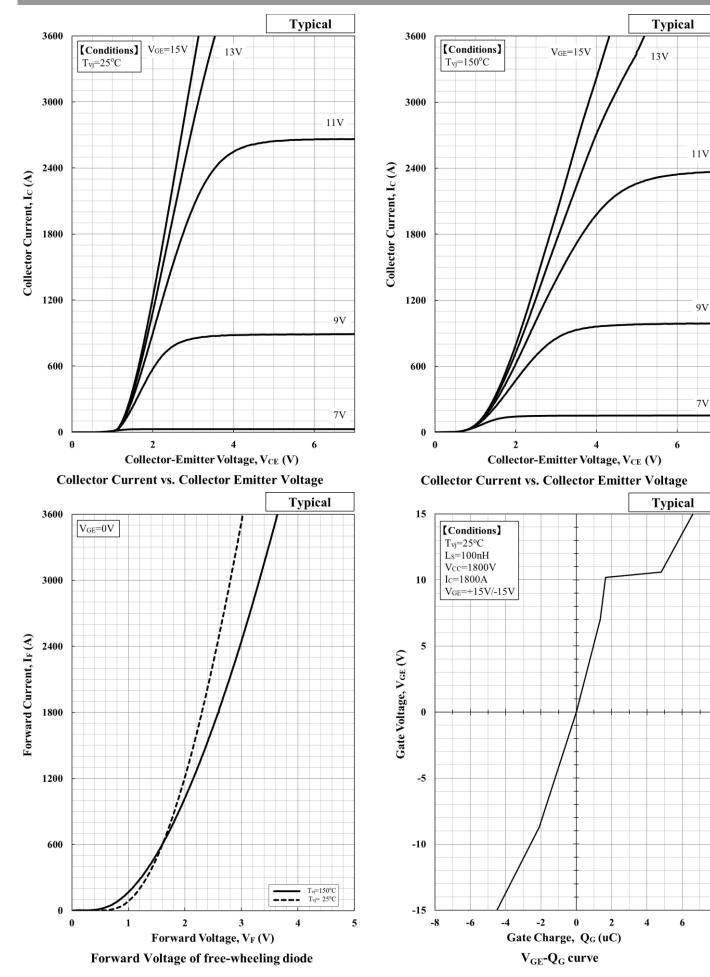
OUTLINE DRAWING

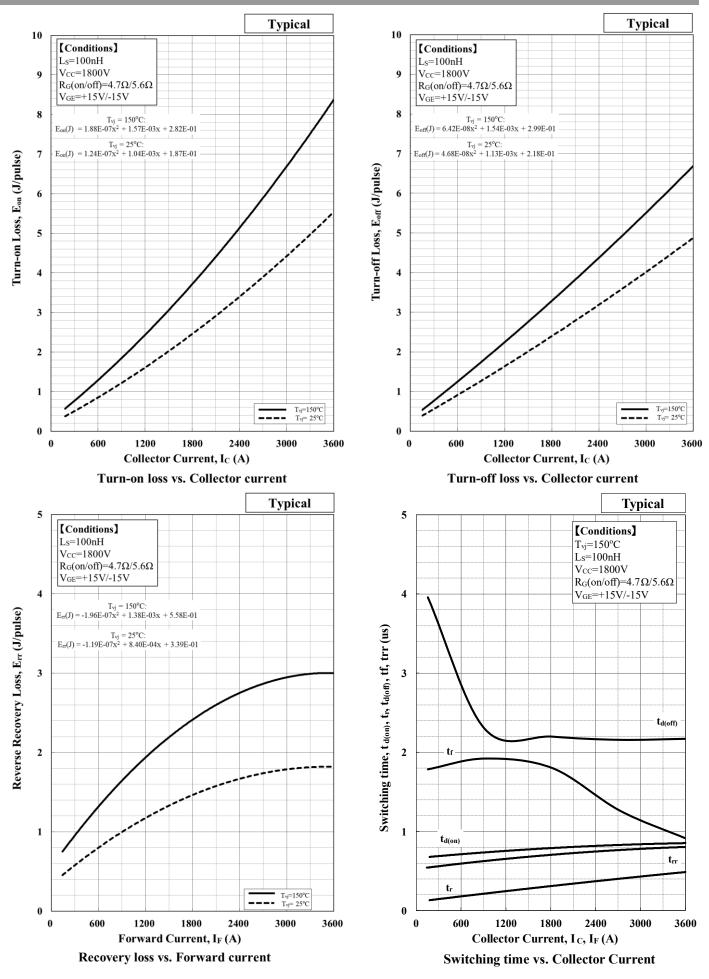


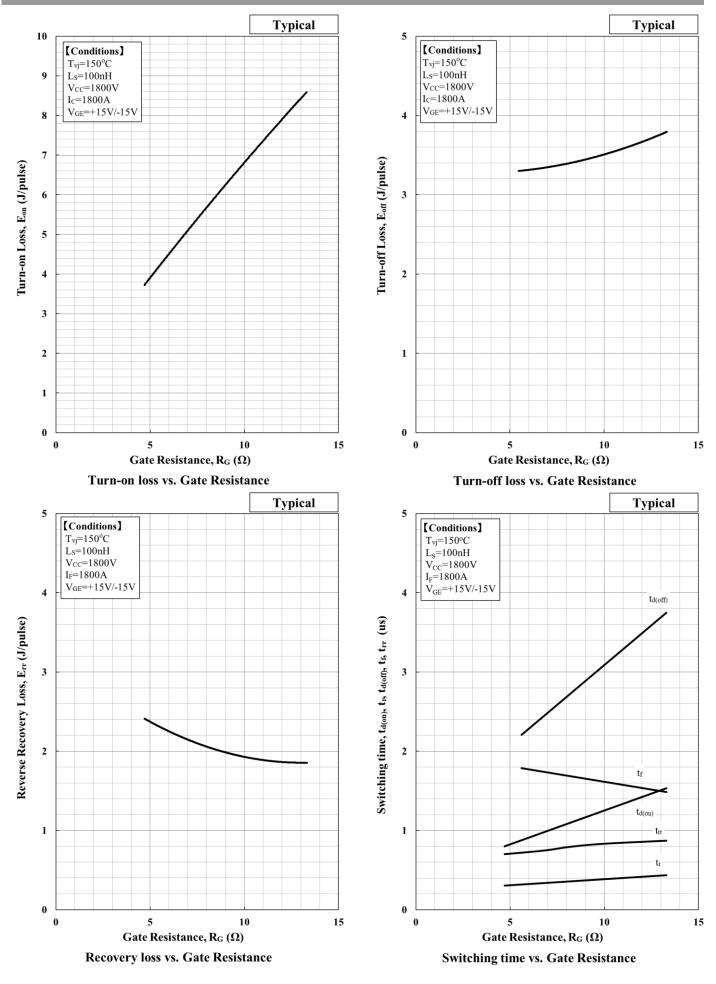
CIRCUIT DIAGRAM

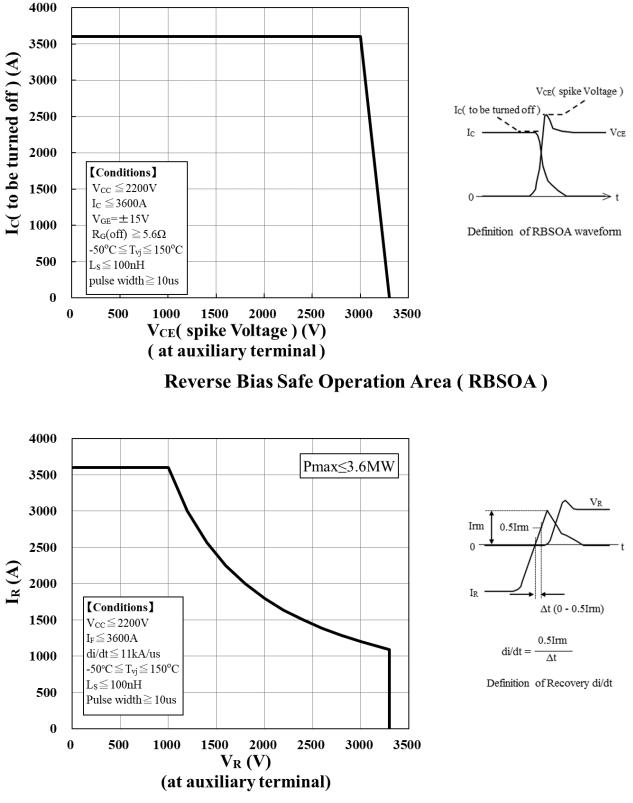


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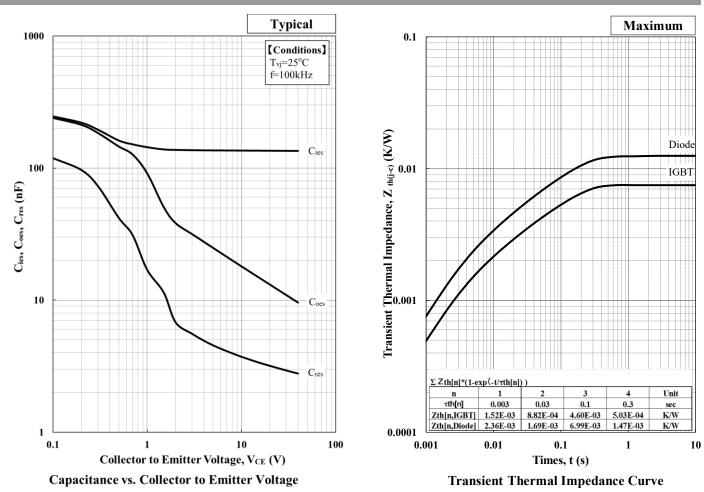








Reverse Recovery Safe Operation Area (RRSOA)



Minebea POWER SEMICONDUCTORS

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Minebea POWER SEMICONDUCTORS

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